

NPN POWER SILICON TRANSISTOR

Qualified per MIL-PRF-19500/534

DEVICES

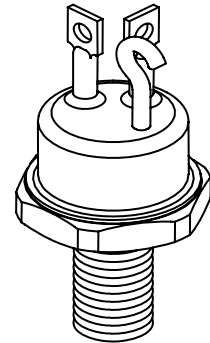
2N5002 2N5004

LEVELS

**JAN
 JANTX
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 JANS**

ABSOLUTE MAXIMUM RATINGS ($T_C = +25^\circ\text{C}$ unless otherwise noted)

| Parameters / Test Conditions | Symbol | Value | Unit |
|---|-----------------|-------------|--------------------|
| Collector-Emitter Voltage | V_{CEO} | 80 | V |
| Collector-Base Voltage | V_{CBO} | 100 | V |
| Emitter-Base Voltage | V_{EBO} | 5.5 | V |
| Collector Current | $I_C^{(3)}$ | 5.0 10 | A |
| Total Power Dissipation @ $T_A = +25^\circ\text{C}^{(1)}$ @ $T_C = +25^\circ\text{C}^{(2)}$ | P_T | 2.0 58 | W |
| Operating & Storage Junction Temperature Range | T_J, T_{stg} | -65 to +200 | $^\circ\text{C}$ |
| Thermal Resistance, Junction-to Case | $R_{\theta JC}$ | 3.0 | $^\circ\text{C/W}$ |
| Thermal Resistance, Junction-to Ambient | $R_{\theta JA}$ | 88 | $^\circ\text{C/W}$ |



TO-59

Note:

- 1) Derate linearly 11.4 mW/ $^\circ\text{C}$ for $T_A > +25^\circ\text{C}$
- 2) Derate linearly 331 mW/ $^\circ\text{C}$ for $T_C > +25^\circ\text{C}$
- 3) This value applies for $P_W \leq 8.3$ ms, duty cycle $\leq 1\%$

ELECTRICAL CHARACTERISTICS ($T_A = +25^\circ\text{C}$, unless otherwise noted)

| Parameters / Test Conditions | Symbol | Min. | Max. | Unit |
|---|---------------|------|------------|---------------------------|
| OFF CHARACTERISTICS | | | | |
| Collector-Emitter Breakdown Voltage $I_C = 100\text{mA dc}$ | $V_{(BR)CEO}$ | 80 | | Vdc |
| Collector-Emitter Cutoff Current $V_{CE} = 40\text{Vdc}, I_B = 0$ | I_{CEO} | | 50 | $\mu\text{A dc}$ |
| Collector-Emitter Cutoff Current $V_{CE} = 60\text{Vdc}, V_{BE} = 0\text{Vdc}$ $V_{CE} = 100\text{Vdc}, V_{BE} = 0\text{Vdc}$ | I_{CES} | | 1.0 1.0 | $\mu\text{A dc}$ mA dc |
| Emitter-Base Cutoff Current $V_{BE} = 4.0\text{Vdc}, I_C = 0$ $V_{BE} = 5.5\text{Vdc}, I_C = 0$ | I_{EBO} | | 1.0 1.0 | mA dc |

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DYNAMIC CHARACTERISTICS

| Parameters / Test Conditions | Symbol | Min. | Max. | Unit |
|--|---------------|------|-------------|------|
| Forward-Current Transfer Ratio $I_C = 50\text{mA}$, $V_{CE} = 5.0\text{Vdc}$ $I_C = 2.5\text{A}$, $V_{CE} = 5.0\text{Vdc}$ $I_C = 5.0\text{A}$, $V_{CE} = 5.0\text{Vdc}$ | h_{FE} | 20 | --- | |
| 2N5002 | | 30 | 90 | |
| | | 20 | --- | |
| $I_C = 50\text{mA}$, $V_{CE} = 5.0\text{Vdc}$ $I_C = 2.5\text{A}$, $V_{CE} = 5.0\text{Vdc}$ $I_C = 5.0\text{A}$, $V_{CE} = 5.0\text{Vdc}$ | 2N5004 | 50 | --- | |
| | | 70 | 200 | |
| | | 40 | --- | |
| Base-Emitter Voltage Non-Saturated $V_{CE} = 5.0\text{Vdc}$, $I_C = 2.5\text{A}$ | V_{BE} | | 1.45 | Vdc |
| Collector-Emitter Saturation Voltage $I_C = 2.5\text{A}$, $I_B = 250\text{mA}$ $I_C = 5.0\text{A}$, $I_B = 500\text{mA}$ | $V_{CE(sat)}$ | | 0.75 1.5 | Vdc |
| Base-Emitter Saturation Voltage $I_C = 2.5\text{A}$, $I_B = 250\text{mA}$ $I_C = 5.0\text{A}$, $I_B = 500\text{mA}$ | $V_{BE(sat)}$ | | 1.45 2.2 | Vdc |

DYNAMIC CHARACTERISTICS

| Parameters / Test Conditions | Symbol | Min. | Max. | Unit |
|---|------------|------|------|------|
| Magnitude of Common Emitter Small-Signal Short-Circuit Forward Current Transfer Ratio $I_C = 500\text{mA}$, $V_{CE} = 5.0\text{Vdc}$, $f = 10\text{MHz}$ | $ h_{fe} $ | 6.0 | | |
| 2N5002 2N5004 | | 7.0 | | |
| Output Capacitance $V_{CB} = 10\text{Vdc}$ | C_{obo} | | 250 | pF |

SWITCHING CHARACTERISTICS

| Parameters / Test Conditions | Symbol | Min. | Max. | Unit |
|---|-----------|------|------|---------------|
| Turn-On Time $I_C = 5\text{A}$; $I_{B1} = 500\text{mA}$ | t_{on} | | 0.5 | μs |
| Storage Time $I_{B2} = -500\text{mA}$ | t_s | | 1.4 | μs |
| Fall Time $V_{BE(OFF)} = 3.7\text{Vdc}$ | t_f | | 0.5 | μs |
| Turn-Off Time $R_L = 6\Omega$ | t_{off} | | 1.5 | μs |

SAFE OPERATING AREA

| |
|--|
| DC Tests $T_C = +25^\circ\text{C}$, $V_{CE} = 0$, $t_p = 1\text{s}$, 1 Cycle Test 1 $V_{CE} = 12\text{Vdc}$, $I_C = 5.0\text{A}$ Test 2 $V_{CE} = 32\text{Vdc}$, $I_C = 1.7\text{A}$ Test 3 $V_{CE} = 80\text{Vdc}$, $I_C = 100\text{mA}$ |
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